

Notic of References Cited	Application/Control No. 10/656,142	Applicant(s)/Patent Under Reexamination SEKIKAWA ET AL.
	Examiner H.Jey Tsai	Art Unit 2812

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*	A	US-6,069,036	05-2000	Kim, Jae-Kap	438/238
	B	US-			
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	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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